

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

APPLICANTS: WEBER, M.A. 1 PCT
PCT NO.: PCT/DE2003/003781
FILED: NOVEMBER 14, 2003
TITLE: DEVICE AND METHOD FOR MEASURING SURFACES ON THE
INTERNAL WALLS OF CYLINDERS USING CONFOCAL MICRO-
SCOPES

INFORMATION DISCLOSURE STATEMENT


MAIL STOP PCT

Commissioner of Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Dear Sir:

Applicant is enclosing Form PTO-1449 disclosing the references cited in the International Search Report, copy enclosed. As it is believed that copies of the references cited in the Search Report were forwarded by the International Office, we are not enclosing copies of these references. Since the instant Information Disclosure Statement is being filed concurrently with the application, no official fee is required in connection with the same. It is respectfully requested that the foregoing Information Disclosure Statement be incorporated into the official file of the concurrently-filed PCT patent application.

Respectfully submitted,
Mark A. WEBER


Allison C. Collard, Reg. No. 22,532
Edward R. Freedman, Reg. No. 26,048
Attorneys for Applicants

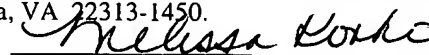
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Roslyn, New York 11576
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Enclosures: PTO-1449 form and International Search Report

EXPRESS MAIL NO. EL 723897846 US

Date of Deposit May 10, 2005

I hereby certify that this paper or fee is being deposited with the United States Postal Service "Express Mail Post Office to Addressee" service under 37 C.F.R. § 1.10, on the date indicated above, and is addressed to the Commissioner of Patents, P.O. Box 1450, Alexandria, VA 22313-1450.


Melissa Konko

FORM PTO-1449 (REV. 7-80)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. : WEBER, M.A. 1 PCT		SERIAL NO. 10/534395	
LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT: Mark A. WEBER			
FILING DATE:				GROUP:			

U.S. PATENT DOCUMENTS							
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
	AA	4,055,382	10/1977	Ziekman, et al.			
	AB	4,963,018	10/1990	West			
	AC	5 640 270	6/1997	Aziz et al.			
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						

FOREIGN PATENT DOCUMENTS								
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION		
						YES	NO	
	AL	EP 0 810 457	12/1997	Europe				
	AM							
	AN							
	AO							
	AP							

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)			
EXAMINER INITIAL	AR		"Endoscope-compatible confocal microscope using a gradient index-lens system", Knittel J. et al., Optics Communications, North-Holland Publishing Co. Amsterdam, NL, vol. 188, no. 5-6, pages 267-273, February 15, 2001.
	AS		

EXAMINER	DATE CONSIDERED
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.